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标题: Thermalization of photoexcited carriers in bismuth investigated by time-resolved terahertz spectroscopy and ab initio calculations

作者: Timrov, I (Timrov, I.); Kampfrath, T (Kampfrath, T.); Faure, J (Faure, J.); Vast, N (Vast, N.); Ast, CR (Ast, C. R.); Frischkorn, C (Frischkorn, C.); Wolf, M (Wolf, M.); Gava, P (Gava, P.); Perfetti, L (Perfetti, L.)

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摘要: The charge carrier dynamics of photoexcited bismuth generates a Drude response that evolves over time. Our data show that the plasma frequency of bismuth displays an initial increase and a subsequent decay. We have performed ab initio calculations on bulk bismuth within the density functional theory and show that this peculiar behavior is due to local extrema in the valence and conduction bands. It follows that most of the carriers first accumulate in these extrema and reach the Fermi level only 0.6 ps after the photoexcitation.

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地址: [Timrov, I.; Faure, J.; Vast, N.; Gava, P.; Perfetti, L.] Ecole Polytech, Solides Irradies Lab, CEA DSM, CNRS UMR 7642, F-91128 Palaiseau, France

[Kampfrath, T.; Frischkorn, C.; Wolf, M.; Perfetti, L.] Free Univ Berlin, Fachbereich Phys, D-14195 Berlin, Germany

[Kampfrath, T.; Frischkorn, C.; Wolf, M.] Max Planck Gesell, Fritz Haber Inst, D-14195 Berlin, Germany

[Ast, C. R.] Max Planck Inst Festkorperforsch, DE-70569 Stuttgart, Germany

通讯作者地址: Timrov, I (通讯作者),Ecole Polytech, Solides Irradies Lab, CEA DSM, CNRS UMR 7642, F-91128 Palaiseau, France

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